MONOLITHIC INTEGRATION OF A METALENS WITH A SURFACE TRAP FOR EFFICIENT FLUORESCENCE COLLECTION OF TRAPPED IONS OVER A WIDE AREA

STUDENTS: HAE LIM, JOHANNES FROECH, CHRISTIAN PLUCHAR, ARKA MAJUMDAR, SARA MOURADIAN

Introduction

- To implement practical trapped-ion quantum computers, we need an imaging system with a high maximum collection efficiency and a larger full width near the maximum (FWNM) of collection efficiency.
- With a two-lens optical system, even a small increase in the numerical aperture (NA) of the collimating lens causes a large decrease in the FWNM.
- Replacing the single collimating lens with multiple smaller ones not only makes the FWNM robust to a change in the FWNM but also increases it.



System & Device

- · A surface trap with a slot for fluorescence collection through the device
- Integration of a metalens below the device for fluorescence collimation
- A thick Si substrate to mitigate motional heating of ions due to the BSG
- An undercut to the Si substrate to enhance collection efficiency





- ftrap, x = 0.37 and ftrap, y = 0.40
- hnull = 125 μm and Collection Efficiency with Undercut (without Undercut) = 0.91 % (0.20 %)

Simulation





Measurement

Maximum Detection Efficiency for Setup I (Setup C) = 0.28 % (0.54 %)
FWNM for Setup I (Setup C) = 5.000 mm (0.926 mm)





Future Work

- Building a fully-functioning ultra-high-vacuum chamber to verify the performance of the setup with real trapped ions
- Monolithic integration of a single metalens for not only fluorescence collection but also control of trapped ions as qubits

Acknowlegements

- We acknowledge support from NSF award ECCS-22402291 as well as the Advancing Quantum-Enabled Technologies (AQET) traineeship program at the University of Washington.
- Part of this work was conducted at the Washington Nanofabrication Facility / Molecular Analysis Facility, a National Nanotechnology Coordinated Infrastructure (NNCI) site at the University of Washington with partial support from the National Science Foundation via awards NNCI-1542101 and NNCI-2025489.
- This material is also based upon work supported by the National Science Foundation Graduate Research Fellowship under Grant No. DGE-2140004.

ELECTRICAL & COMPUTER ENGINEERING

ADVISOR: SARA MOURADIAN

SPONSOR: ELECTRICAL & COMPUTER ENGINEERING DEPARTMENT, UNIVERSITY OF WASHINGTON

JNIVERSIT<u>y of Washington</u>